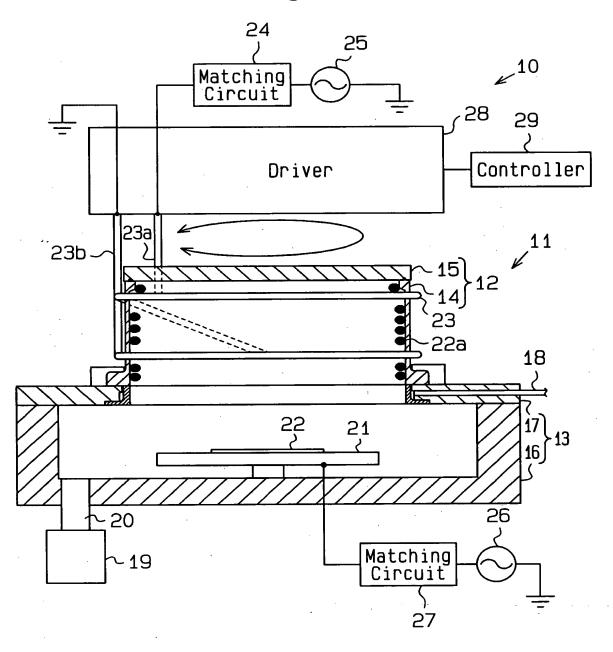
Fig.1



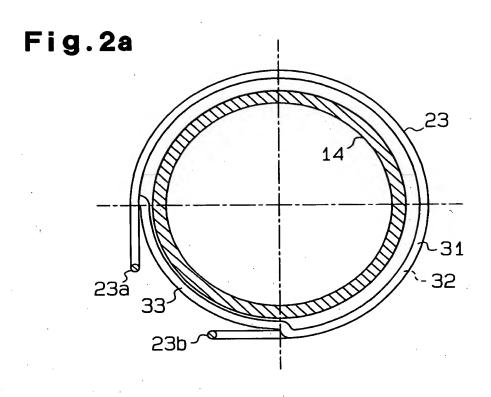
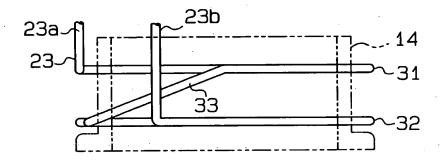
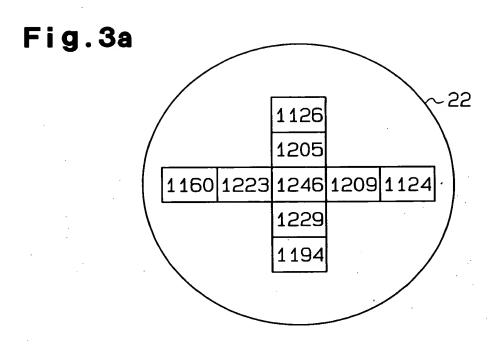


Fig.2b





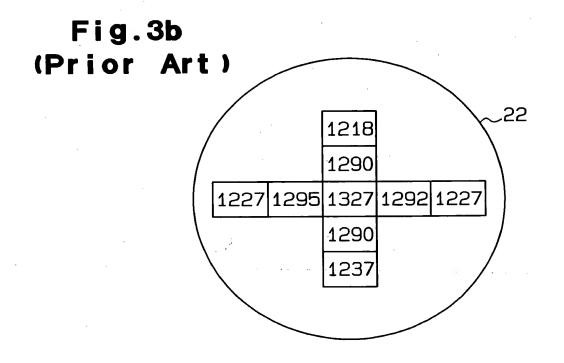


Fig.4

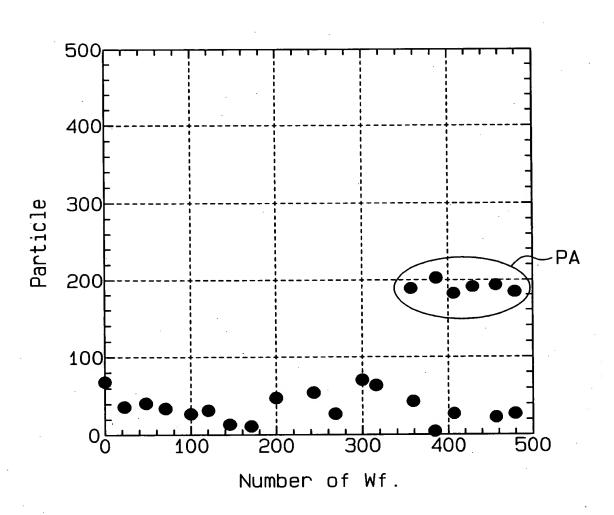
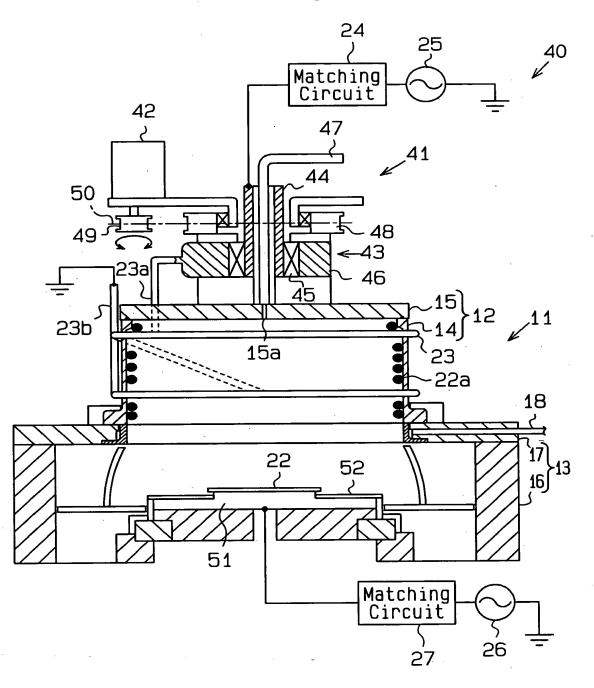


Fig.5

Numbers of wafers rotation		Number of processed wafers	Particle size	Initial particle number	Particle number after processing	Difference	TOTAL
0	0	25	S	19	26	+7	<b>+</b> 31
			SM	1	12	+11	
			М	0	13	+13	
			L	0	0	0	
		100	SM	10	18	+8_	+17
			SM	2	6	+4	
			M	3	8	+5	
			SM	0	0	0	
Approx. 3.75	Approx. 0.52	25	S	24	59	+35	<b>+</b> 43
			SM	3	5	+2	
			М	6	12	+6	
			L	0	0	0	
		100	S	15	15	0	+13
			SM	2	6	+4	
			М	6	15	+9	
			L	0	0	0	
		150	S	21	5	-16	-18
			SM	0	3	+3	
			М	7	2	<b>-</b> 5	
			L	0	0	0	
Approx	Approx. 0.054	25	S	2	23	+21	+33
			SM	1	8	+7	
			М	8	13	+5	
			L	0	0	0	
		100	S	37	13	-24	<b>-</b> 37
			SM	15	6	<b>-</b> 9	
			М	15	10	<b>-</b> 5	
			L	0	1	+1	
Approx 148	. Approx 0.0135	25	S	8	26	+18	+29
			SM	4	7	+3	
			M-	13	21	+8	
			L	0	0	0	
		100	S	22	19	+3	+10
			SM	1	8	+7	
			M	3	9	+6	
			L	0	0	0	
		150	S	12	19	+7	+12
			SM	0	3	+3	
			M	3	3 5	+2	
			L	0	0	0	

Fig.6



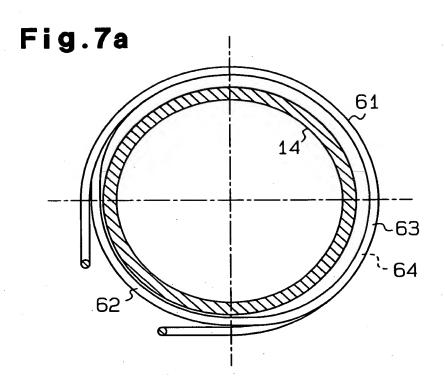
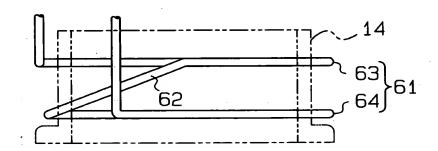


Fig.7b



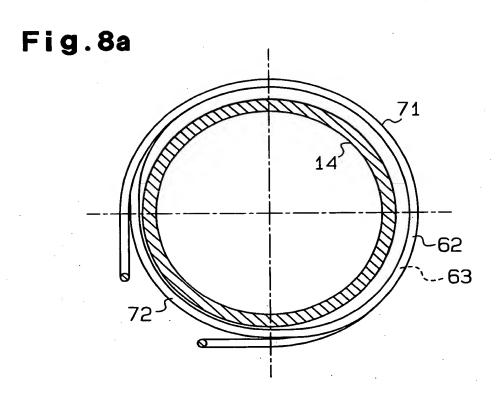


Fig.8b

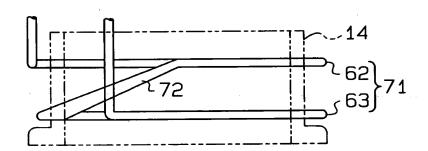


Fig.9a

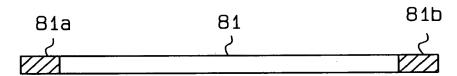


Fig.9b

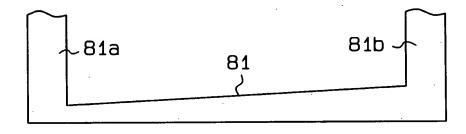


Fig.10a

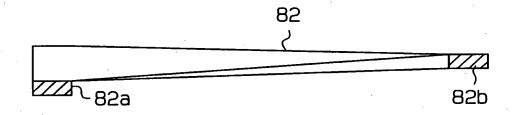


Fig.10b

